

**Search Notes**

Application/Control No.

10/665,312

Examiner

Quoc A. Tran

Applicant(s)/Patent under  
Reexamination

STUPLE ET AL.

Art Unit

2176

**SEARCHED**

Class	Subclass	Date	Examiner
715	530	7/4/2006	
715	532	7/4/2006	
715	516	7/4/2006	
715	517	7/4/2006	

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
INVENTORS SEARCH CHECK FOR DOUBLE PATENT	7/4/2006	
EAST (US-PAT, US-PGPUB.) See Search History Printout	7/4/2006	
ACM Digital Librarysee Search History Printout	7/4/2006	